


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/010,807	TAN ET AL.	
	Examiner	Art Unit	
	Christopher L. Chin	1641	

ISSUE CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
435		7.21			435	7.5	6					
INTERNATIONAL CLASSIFICATION					436	524	525	526	527			
G	0	1	N	33/53								
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(Assistant Examiner) (Date)		<b>CHRISTOPHER L. CHIN</b> <b>PRIMARY EXAMINER</b> <b>GROUP 1800 / 641</b>		Total Claims Allowed: 35	
<i>N. V. Varigou</i> (Legal Instruments Examiner) (Date)		<i>Christopher L. Chin</i> (Primary Examiner) (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original		
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